

Electrical and Thermal Specifications ($T_c = 25^\circ\text{C}$, unless otherwise specified)

Symbol	Parameters	Test Conditions		Min	Typ	Max	Unit
IGBT							
V _{GE(th)}	Gate - Emitter Threshold Voltage	V _{CE} =V _{GE} , I _C =1.6mA		4.9	5.8	6.5	V
V _{CE(sat)}	Collector - Emitter Saturation Voltage	I _C =100A, V _{GE} =15V, T _J =25°C			1.45	1.9	V
		I _C =100A, V _{GE} =15V, T _J =125°C			1.6		V
I _{CES}	Collector Leakage Current	V _{CE} =600V, V _{GE} =0V, T _J =25°C				1	mA
		V _{CE} =600V, V _{GE} =0V, T _J =125°C				5	mA
I _{GES}	Gate Leakage Current	V _{CE} =0V, V _{GE} =±15V, T _J =125°C		-400		400	nA
R _{Gint}	Integrated Gate Resistor				2		Ω
Q _{ge}	Gate Charge	V _{CC} =300V, I _C =100A , V _{GE} =±15V			1.1		μC
C _{ies}	Input Capacitance	V _{CE} =25V, V _{GE} =0V, f =1MHz			6.2		nF
C _{res}	Reverse Transfer Capacitance				0.19		nF
t _{d(on)}	Turn - on Delay Time	V _{CC} =300V I _C =100A R _G =3.3Ω V _{GE} =±15V Inductive Load	T _J =25°C		70		ns
			T _J =125°C		80		ns
t _r	Rise Time		T _J =25°C		20		ns
			T _J =125°C		20		ns
t _{d(off)}	Turn - off Delay Time		T _J =25°C		260		ns
			T _J =125°C		290		ns
t _f	Fall Time		T _J =25°C		70		ns
			T _J =125°C		70		ns
E _{on}	Turn - on Energy		T _J =25°C		0.3		mJ
			T _J =125°C		0.7		mJ
E _{off}	Turn - off Energy		T _J =25°C		2.5		mJ
			T _J =125°C		3.35		mJ
I _{SC}	Short Circuit Current	t _{psc} ≤6μS , V _{GE} =15V; T _J =125°C, V _{CC} =360V			500		A
R _{thJC}	Junction-to-Case Thermal Resistance (Per IGBT)				0.45		K/W
Diode							
V _F	Forward Voltage	I _F =100A , V _{GE} =0V, T _J =25°C			1.55	1.95	V
		I _F =100A , V _{GE} =0V, T _J =125°C			1.50		V
I _{RRM}	Max. Reverse Recovery Current	I _F =100A , V _R =300V di _p /dt=-5100A/μs T _J =125°C			150		A
Q _{rr}	Reverse Recovery Charge				8.0		μC
E _{rec}	Reverse Recovery Energy				2.25		mJ
R _{thJC}	Junction-to-Case Thermal Resistance (Per Diode)				0.75		K/W

Figure 1: Typical Output Characteristics

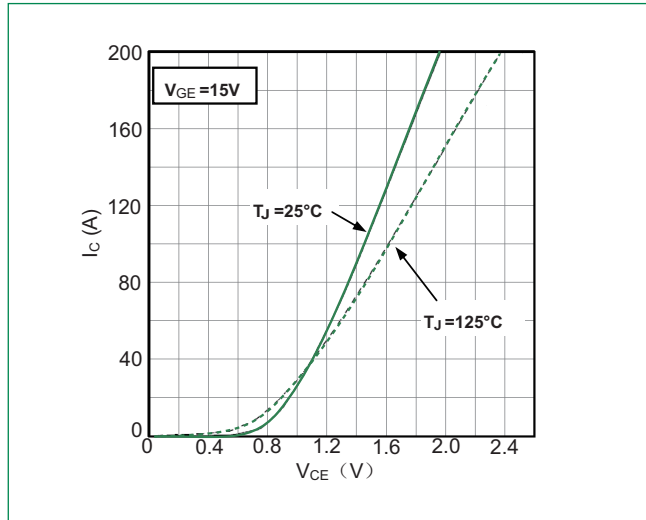


Figure 2: Typical Output characteristics

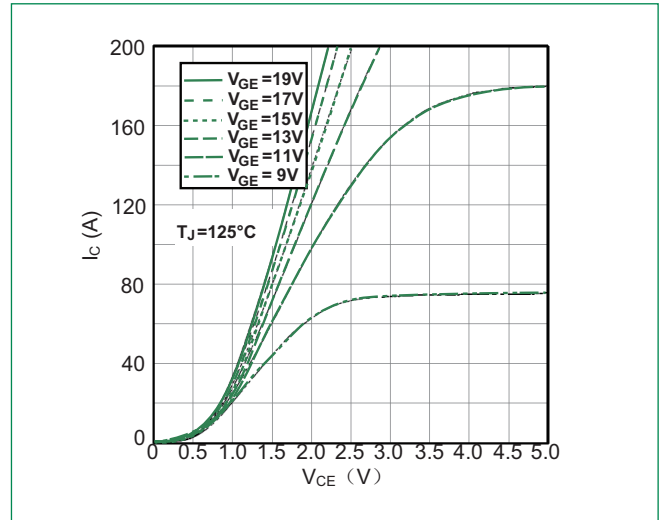


Figure 3: Typical Transfer characteristics

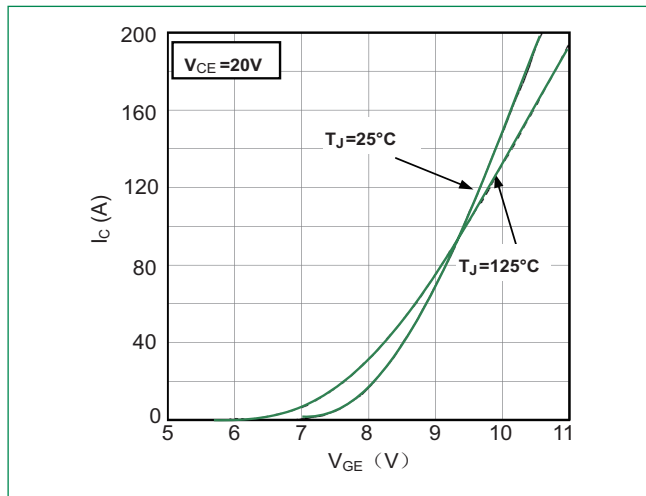


Figure 4: Switching Energy vs. Gate Resistor

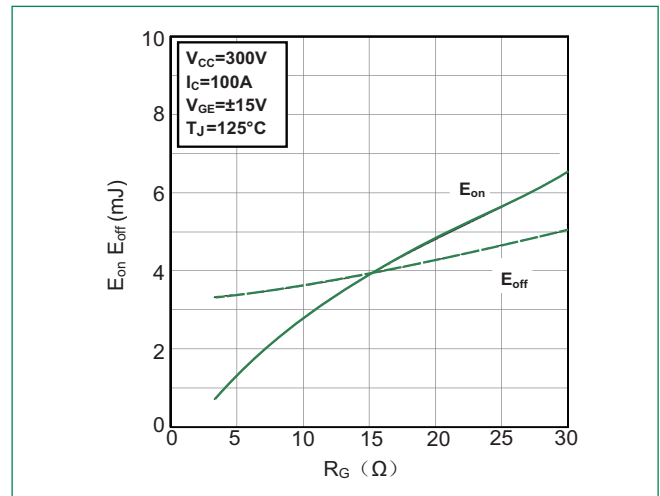


Figure 5: Switching Energy vs. Collector Current

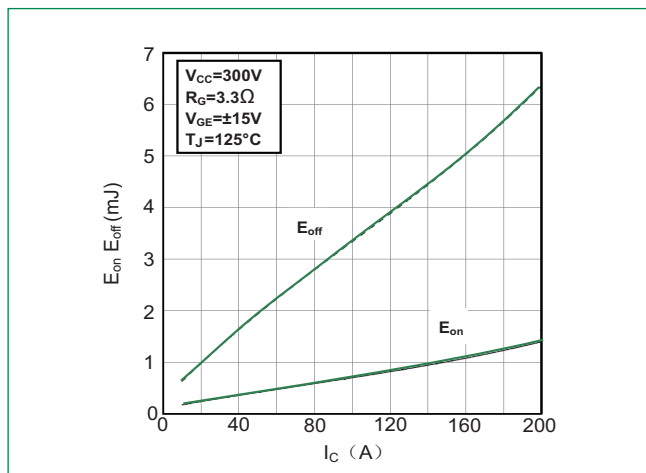


Figure 6: Reverse Biased Safe Operating Area

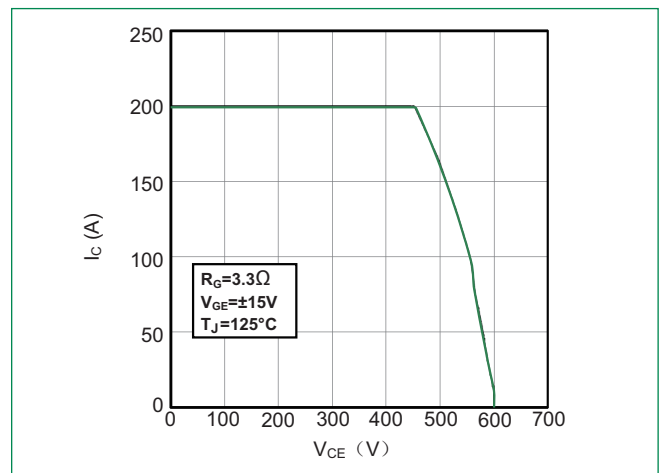


Figure 7: Diode Forward Characteristics

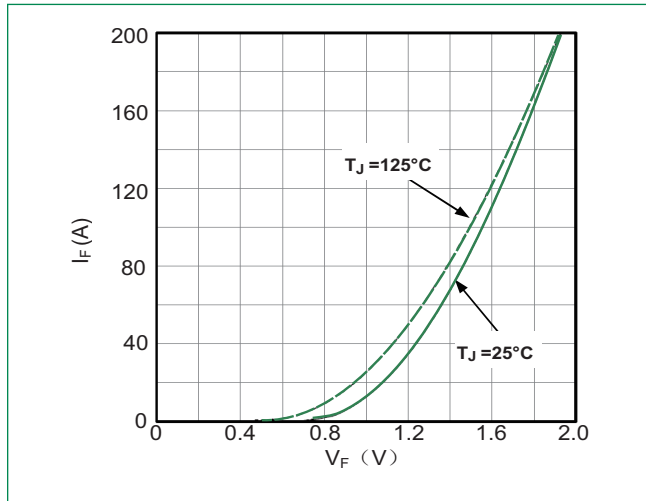


Figure 8: Switching Energy vs. Gate Resistor

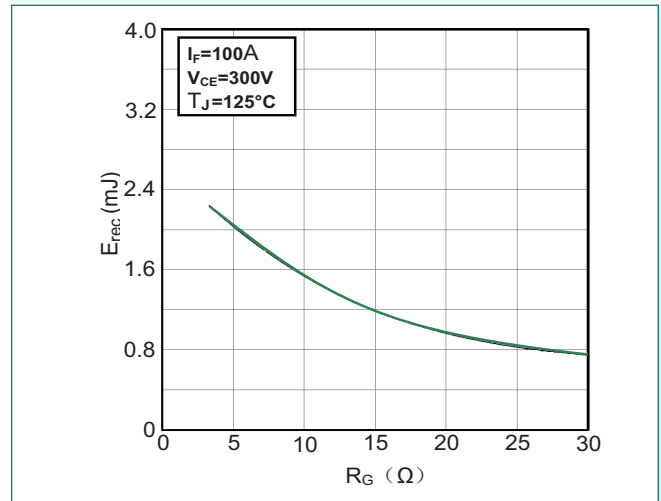


Figure 9: Switching Energy vs. Forward Current

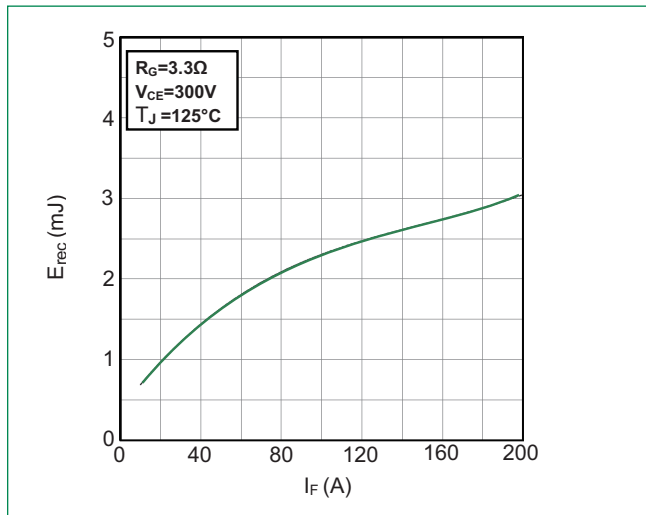


Figure 10: Transient Thermal Impedance

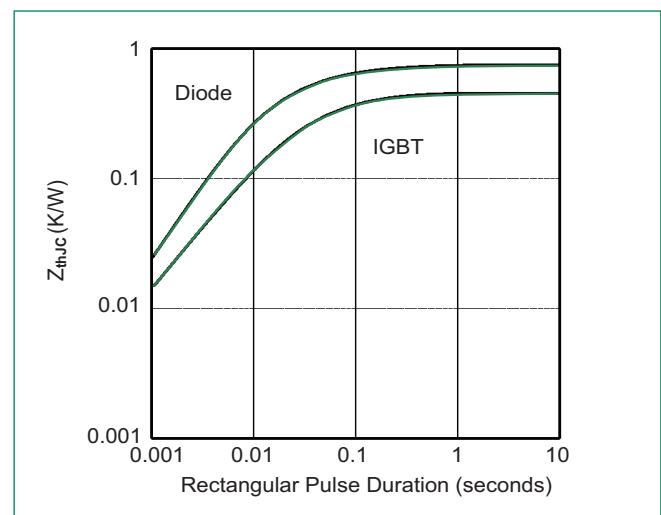
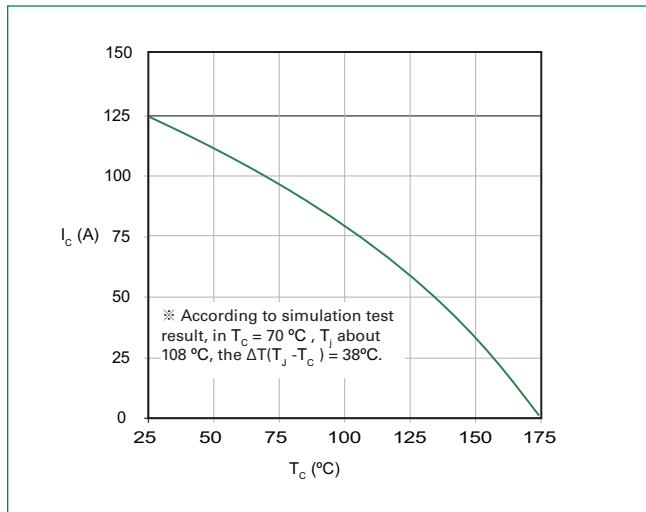
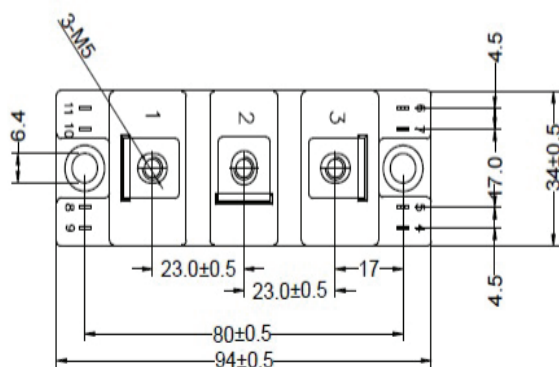
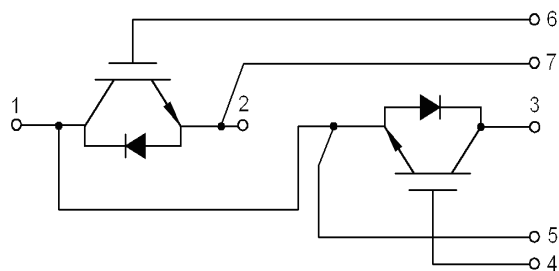


Figure 11: Maximum Continuous Collector Current vs Case Temperature



Circuit Diagram



Part Number	Marking	Weight	Packing Mode	M.O.Q
MG06100S-BN4MM	MG06100S-BN4MM	160g	Bulk Pack	100

Part Marking System

